

Notice of References Cited	Application/Control No. 09/501,182	Applicant(s)/Patent Under Reexamination CHANG ET AL.	
	Examiner Charles E Parsons	Art Unit 2613	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,796,434	08-1998	Lempel, Mody	348/403.1
	B	US-6,498,815	12-2002	Kleihorst et al.	375/240.2
	C	US-5,408,274	04-1995	Chang et al.	348/700
	D	US-6,144,698	11-2000	Poon et al.	375/240.16
	E	US-6,181,831	01-2001	Sadjadian, Ahmad	382/276
	F	US-6,434,196	08-2002	Sethuraman et al.	375/240.12
	G	US-5,883,823	03-1999	Ding, Wei	708/402
	H	US-6,236,679	05-2001	Herluison et al.	375/240
	I	US-6,269,174	07-2001	Koba et al.	382/107
	J	US-5,987,180	11-1999	Reitmeier, Glenn Arthur	382/236
	K	US-6,058,143	05-2000	Golin, Stuart Jay	375/240.16
	L	US-5,710,603	01-1998	Lee, Min-Sup	348/699
	M	US-6,014,181	01-2000	Sun, Kai	348/699

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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